Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/175,156	PUTNAM ET AL.	
Examiner	Art Unit	
Joseph T. Phan	2614	

	SEAR	CHED	
Class	Subclass	Date	Examiner
			•

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
	1		

SEARCH (INCLUDING SEAF)
	DATE	EXMR
Updated East Search	12/6/2007	JTP